

CMOS 12-Bit Buffered Multiplying DAC

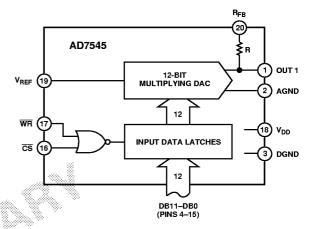
AD7545

FEATURES

12-Bit Resolution
Low Gain TC: 2 ppm/°C typ
Fast TTL Compatible Data Latches
Single +5 V to +15 V Supply
Small 20-Lead 0.3" DIP and 20-Terminal Surface Mount
Packages
Latch Free (Schottky Protection Diode Not Required)
Low Cost

Ideal for Battery Operated Equipment

FUNCTIONAL BLOCK DIAGRAM



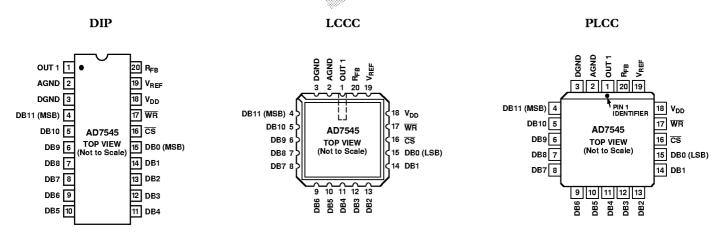
GENERAL DESCRIPTION

The AD7545 is a monolithic 12-bit CMOS multiplying DAC with onboard data latches. It is loaded by a single 12-bit wide word and directly interfaces to most 12- and 16-bit bus systems. Data is loaded into the input latches under the control of the \overline{CS} and \overline{WR} inputs; tying these control inputs low makes the input latches transparent, allowing direct unbuffered operation of the DAC.

The AD7545 is particularly suitable for single supply operation and applications with wide temperature variations.

The AD7545 can be used with any supply voltage from +5 V to +15 V. With CMOS logic levels at the inputs the device dissipates less than 0.5 mW for $V_{\rm DD}$ = +5 V.

PIN CONFIGURATIONS



REV. A

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$\label{eq:continuous} \textbf{AD7545--SPECIFICATIONS} \ \, (\textbf{V}_{\text{REF}} = +10 \, \text{V}, \, \textbf{V}_{\text{OUT1}} = 0 \, \text{V}, \, \text{AGND} = \text{DGND} \ \, \text{unless otherwise noted})$

			= +5 V	$\mathbf{v}_{\mathbf{DD}} = \mathbf{v}_{\mathbf{DD}}$			
D	¥7	Lin		Limi		Thete	Total Constitution of Comments
Parameter	Version	$T_A = +25$ °C	T_{MIN}, T_{MAX}^{1}	$T_A = +25$ °C	$C T_{MIN,} T_{MAX}^{1}$	Units	Test Conditions/Comments
STATIC PERFORMANCE		l				70.	
Resolution	All	12	12	12	12	Bits	
	J, A, S	±2	±2	±2	±2	LSB max	
	K, B, T	±1	±1	±1	±1	LSB max	
	L, C, U	±1/2	±1/2	±1/2	±1/2	LSB max	
D	GL, GC, GU	±1/2	±1/2	±1/2	±1/2	LSB max	
Differential Nonlinearity	J, A, S	±4	±4	±4	±4	LSB max	10-Bit Monotonic T_{MIN} to T_{MAX}
	K, B, T	±1	±1	±1	±1	LSB max	12-Bit Monotonic T _{MIN} to T _{MAX}
	L, C, U	±1	±1	±1	±1	LSB max	12-Bit Monotonic T _{MIN} to T _{MAX}
G : F GI : I I I I I I I I I I I I I I I I I	GL, GC, GU	±1	±1	±1	±1	LSB max	12-Bit Monotonic T _{MIN} to T _{MAX}
Gain Error (Using Internal RFB) ²	J, A, S	±20	±20	±25	±25	LSB max	DAC Register Loaded with
	K, B, T	±10	±10	±15	±15	LSB max	1111 1111 1111
	L, C, U	±5	±6	±10	±10	LSB max	Gain Error Is Adjustable Using
O : FE	GL, GC, GU	±1	±2	±6	±7	LSB max	the Circuits of Figures 4, 5, and 6
Gain Temperature Coefficient ³	1	l		1.40		,,,,	E : 111
ΔGain/ΔTemperature	All	±5	±5	±10	±10	ppm/°C max	Typical Value is 2 ppm/°C for $V_{\rm DD}$ = +5 V
DC Supply Rejection ³							
$\Delta Gain/\Delta V_{DD}$	All	0.015	0.03	0.01	0.02	% per % max	$\Delta V_{\mathrm{DD}} = \pm 5\%$
Output Leakage Current at OUT1	J, K, L, GL	10	50	10	50	nA max	DB0-DB11 = 0 V; \overline{WR} , \overline{CS} = 0 V
	A, B, C, GC	10	50	10	50	nA max	
	S, T, U, GU	10	200	10	200	nA max	
DYNAMIC PERFORMANCE							
Current Settling Time ³	All	2	2	2	2	μs:max	To 1/2 LSB. OUT1 Load = 100 Ω. DAC
Ü						. ***	Output Measured from Falling Edge of
				885			$\overline{WR}, \overline{CS} = 0.$
Propagation Delay ³ (from Digital					. 33		,
Input Change to 90%							
of Final Analog Output)	All	300	🛞	250	· · · · · · · · · · · · · · · · · · ·	ns max	OUT1 Load = 100 Ω , C_{EXT} = 13 pF ⁴
Digital-to-Analog Glitch Inpulse	All	400		250		nV sec typ	V _{REF} = AGND
AC Feedthrough ⁵	7111	100		29.0		on v see typ	V REF - MOND
At OUT1	All	5	5	5		mV p-p typ	V_{REF} = ±10 V, 10 kHz Sinewave
	1111		- 	- 7 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 - 000 -	. 334	штррцр	VREF 210 V, 10 KHZ office wave
REFERENCE INPUT	1		- 1999 - 1997 - 1996		8. Y		
Input Resistance	All		~ 7	<i></i>	7	kΩ min	Input Resistance TC = -300 ppm/°C typ
(Pin 19 to GND)	7888	25	25	25	25	kΩ max	Typical Input Resistance = 11 k Ω
ANALOG OUTPUT	1 %			0330.			
Output Capacitance ³	2000		19000001 1100011 19000 11000		***		
C _{OUT1}	All	70	70	70	70	pF max	DB0-DB11 = 0 V, \overline{WR} , \overline{CS} = 0 V
C_{OUT1}		200	200	200	200	pF max	DB0-DB11 = V_{DD} , \overline{WR} , \overline{CS} = 0 V
DIGITAL INPUTS				40000000			
Input High Voltage							
V _{IH}	All	2.4	2.4	13.5	13.5	V min	
Input Low Voltage	1	=/-1		10.0	13.3	,	
V _{IL}	All	0.8	0.8	1.5	1.5	V max	
Input Current ⁶	1 ****	0.0	0.0	1.5	1.5	V max	
*	All	±1	±10	±1	±10	μA max	$V_{IN} = 0 \text{ or } V_{DD}$
I _{IN} Input Capacitance ³	7111		110	-1	±10	μιτιιαχ	VIN = 0 OI VDD
DB0-DB11	All	5	5	5	5	pF max	$V_{IN} = 0$
WR, CS	All	20	20	20	20	pF max	
	All	20	20	20	20	pr max	$V_{IN} = 0$
SWITCHING CHARACTERISTICS 7							
Chip Select to Write Setup Time	All	280	380	180	200	ns min	See Timing Diagram
t_{CS}		200	270	120	150	ns typ	
Chip Select to Write Hold Time							
t _{CH}	All	0	0	0	0	ns min	
Write Pulse Width							
t _{wr}	All	250	400	160	240	ns min	$t_{CS} \ge t_{WR}, t_{CH} \ge 0$
		175	280	100	170	ns typ	
Data Setup Time	All	140	210	90	120	ns min	
t _{DS}		100	150	60	80	ns typ	
Data Hold Time						'-	
$t_{ m DH}$	All	10	10	10	10	ns min	
POWER SUPPLY							
	Δ11	2	2	2	2		All Digital Inputs V or V
I_{DD}	All	1				mA max	All Digital Inputs V _{IL} or V _{IH}
		100	500	100	500	μA max	All Digital Inputs 0 V to V _{DD}
		10	10	10	10	μA typ	All Digital Inputs 0 V to V _{DD}

NOTES

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¹Temperature range as follows: J, K, L, GL versions, 0°C to +70°C; A, B, C, GC versions, -25°C to +85°C; S, T, U GU versions, -55°C to +125°C.

²This includes the effect of 5 ppm max gain TC.

³Guaranteed but not tested.

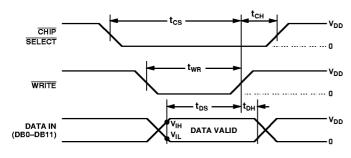
 $^{^4\}mathrm{DB0-DB11}$ = 0 V to V_{DD} or V_{DD} to 0 V.

⁵Feedthrough can be further reduced by connecting the metal lid on the ceramic package (Suffix D) to DGND.

⁶Logic inputs are MOS gates. Typical input current (+25°C) is less than 1 nA.

⁷Sample tested at +25°C to ensure compliance.

Specifications subject to change without notice.



Write Cycle Timing Diagram

MODE SELECTION

WI	RITE MODE:	HOLD MODE:
	S AND WR LOW, DAC RESPONDS D DATA BUS (DB0-DB11) INPUTS.	EITHER CS OR WR HIGH, DATA BUS (DB0-DB11) IS LOCKED OUT; DAC HOLDS LAST DATA PRESENT WHEN WR OR CS ASSUMED HIGH STATE.

NOTES:

V_{DD} = +5V; t_r = t_f = 20ns

 V_{DD} = +15V; t_r = t_f = 40ns ALL INPUT SIGNAL RISE AND FALL TIMES MEASURED FROM 10% TO

90% OF V_{DD}.
TIMING MEASUREMENT REFERENCE LEVEL IS V_{IH} + V_{II}/2.

ABSOLUTE MAXIMUM RATINGS*

 $(T_A = + 25^{\circ}C \text{ unless otherwise noted})$

V_{DD} to DGND
Digital Input Voltage to DGND0.3 V, V _{DD} +0.3 V
V_{RFB} , V_{REF} to DGND $\pm 25 \text{ V}$
V_{PIN1} to DGND0.3 V, V_{DD} +0.3 V
AGND to DGND -0.3 V , $V_{DD} + 0.3 \text{ V}$
Power Dissipation (Any Package) to +75°C 450 mW
Derates above +75°C 6 mW/°C
Operating Temperature

Commercial (J, K, L, GL) Grades 0°C to +70°C
Industrial (A, B, C, GC) Grades25°C to +85°C
Extended (S, T, U, GU) Grades –55°C to +125°C
Storage Temperature65°C to +150°C
Lead Temperature (Soldering, 10 secs) +300°C

^{*}Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD7545 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



TERMINOLOGY RELATIVE ACCURACY

The amount by which the D/A converter transfer function differs from the ideal transfer function after the zero and fullscale points have been adjusted. This is an endpoint linearity measurement.

DIFFERENTIAL NONLINEARITY

The difference between the measured change and the ideal change between any two adjacent codes. If a device has a differential nonlinearity of less than 1 LSB it will be monotonic, i.e., the output will always increase for an increase in digital code applied to the D/A converter.

PROPAGATION DELAY

This is a measure of the internal delay of the circuit and is measured from the time a digital input changes to the point at which the analog output at OUT1 reaches 90% of its final value.

DIGITAL-TO-ANALOG GLITCH IMPULSE

This is a measure of the amount of charge injected from the digital inputs to the analog outputs when the inputs change state. It is usually specified as the area of the glitch in nV secs and is measured with V_{REF} = AGND and an ADLH0032CG as the output op amp, C1 (phase compensation) = 33 pF.

ORDERING GUIDE1

Model ²	Temperature Range	Relative Accuracy	Maximum Gain Error $T_A = +25^{\circ}C$ $V_{DD} = +5 V$	Package Options ³
AD7545JN	0°C to +70°C	±2 LSB	±20 LSB	N-20
AD7545AQ	−25°C to +85°C	±2 LSB	±20 LSB	Q-20
AD7545SQ	−55°C to +125°C	±2 LSB	±20 LSB	Q-20
AD7545KN	0°C to +70°C	±1 LSB	±10 LSB	N-20
AD7545BQ	−25°C to +85°C	±1 LSB	±10 LSB	Q-20
AD7545TQ	−55°C to +125°C	±1 LSB	±10 LSB	Q-20
AD7545LN	0°C to +70°C	$\pm 1/2$ LSB	±5 LSB	N-20
AD7545CQ	−25°C to +85°C	±1/2 LSB	±5 LSB	Q-20
AD7545UQ	−55°C to +125°C	±1/2 LSB	±5 LSB	Q-20
AD7545GLN	0°C to +70°C	±1/2 LSB	±1 LSB	N-20
AD7545GCQ	−25°C to +85°C	±1/2 LSB	±1 LSB	Q-20
AD7545GUQ	−55°C to +125°C	±1/2 LSB	±1 LSB	Q-20
AD7545JP	0°C to +70°C	±2 LSB	±20 LSB	P-20A
AD7545SE	−55°C to +125°C	±2 LSB	±20 LSB	E-20A
AD7545KP	0°C to +70°C	±1 LSB	±10 LSB	P-20A
AD7545TE	−55°C to +125°C	±1 LSB	±10 LSB	E-20A
AD7545LP	0°C to +70°C	±1/2 LSB	±5 LSB	P-20A
AD7545UE	−55°C to +125°C	±1/2 LSB	±5 LSB	E-20A
AD7545GLP	0°C to +70°C	±1/2 LSB	±1 LSB	P-20A
AD7545GUE	−55°C to +125°C	±1/2 LSB	±1 LSB	E-20A

NOTES

¹Analog Devices reserves the right to ship either ceramic (D-20) in lieu of cerdip packages (O-20).

²To order MIL-STD-883, Class B process parts, add /883B to part number. Contact local sales office for military data sheet. For U.S. Standard Military DRAWING (SMD) see DESC drawing 5962-87702.

³E = Leadless Ceramic Chip Carrier; N = Plastic DIP; P = Plastic Leaded Chip Carrier; Q = Cerdip.

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